

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/518,937	DIVAKARAN ET AL.	
Examiner	Art Unit	
Maikhanh Nguyen	2176	

SEARCHED				
Class	Subclass	Date	Examiner	
Updated	Search	8/6/2005	MK	
Updated	Search	12/22/2005	MK	
Updated	Search	11/28/2006	MK	
Updated	Search	7/11/2007	MK	
Updated	Search	1/2/2008	MK	
Updated	Search	1/4/2008	MK	
715	723	1/4/2008	MK	
382	190 232	1/4/2008	MK	
345	440	1/4/2008	MK	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
715	501.1 723	1/4/2008	мк	
382	190 232	1/4/2008	MK	
345	440	1/4/2008	MK	
USPAT	USPGPub	1/4/2008	MK	

SEARCH NOT (INCLUDING SEARCH		<u> </u>
·	DATE	EXMR
West Updated (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout I	8/6/2005	MK
West Updated (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout I	2/22/2005	MK
NPL (ACM, IEEE) See Search History Printout	7/11/2007	MK
West Updated (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	7/11/2007	МК
West Updated (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	1/2/2008	МК
Consulted with Primary William Bashore	1/3/2008	МК
West Updated (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	1/4/2008	мк
Interference Search	1/4/2008	MK